

**Notice of References Cited**

Application/Control No.

10/593,632

Applicant(s)/Patent Under  
Reexamination  
MUKAI ET AL.

Examiner

MARIA J. LAIOS

Art Unit

1795

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,344,803	03-2008	Ueki et al.	429/223
	C	US-			
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	F	US-			
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	K	US-			
	L	US-			
	M	US-			

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	N	WO 2003/103080	12-2003	WIPO	Miyamoto et al.	H01M 6/08
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	R					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	W	
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